Parasitic Extraction Involving 3-D Conductors Based on Multilayered Green's Function

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# Abstract

- An algorithm for capacitance extraction based on Green's function involving 3-D conductors, considering multi-layered dielectric and lossy substrate
- An Improvement based on an algorithm implemented in ASITIC, for which the metal thickness cannot be included.
- A numerically stable and analytically integrable formula for the Green's function in vertical direction is derived
- The Green's function is integrated over the sidewalls
- The coefficient of potential is efficiently calculated by looking up the table of DCT, DCST and DST

# Outline

- Background
- DCT based Green's function method
- Our algorithm
- Result and Comparison
- Conclusion

## Capacitive Parasitic Extraction Based on BEM

# $\mathbf{P}\mathbf{q} = \mathbf{v}$

- Computing the coefficient-of-potential  $P_{ij}$ 
  - Free space method (Direct BEM)
  - Green's function method
- Solving the equation Pq=v
  - LU decomposition

. . .

- <u>Fast Multi-pole Method</u> (J. White, MIT)
- <u>Singular Value Decomposition (S. Kapur, Bell Lab)</u>
- Hierarchical Method (W. Shi, TAMU)
- <u>Quasi Multiple Media (W. Yu, THU)</u>

kernel independent

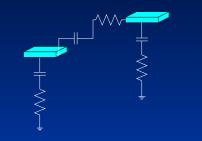
### **Advantages of Green's Function Method**

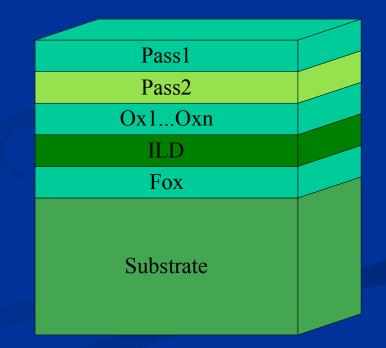
#### Direct BEM method

- Discretize the interfaces between each adjacent dielectrics
- A Large number of variables

Green's function method

- Layout independent Green's function for technology is solved first
- Dielectric information is included in the Green's function
- Only conductors need to be discretized
- Limited to some certain profiles.





### **DCT Based Green's Function Method**

- Based on multi-layered Green's function
- First proposed by R. Gharpurey in 1996 to analyze the effect of substrate coupling
- Numerically stabilized by A.M. Niknejad in 1998
- Developed to an academic software, ASITIC, which can simulate all kinds of passive elements.
- Conductors are assumed to be <u>infinitely thin</u>, *i.e.*, the thickness is ignored
- Direct extending to 3-D meets problems

[R. Gharpurey, CICC'96]

[A.M. Niknejad, TCAD'98]

## **Metal thickness**

- Metal width and spacing are getting smaller and smaller, while the thickness is not reducing, sometimes even increases.
- Metal thickness should be considered.

### Boundary Conditions and Green's Function

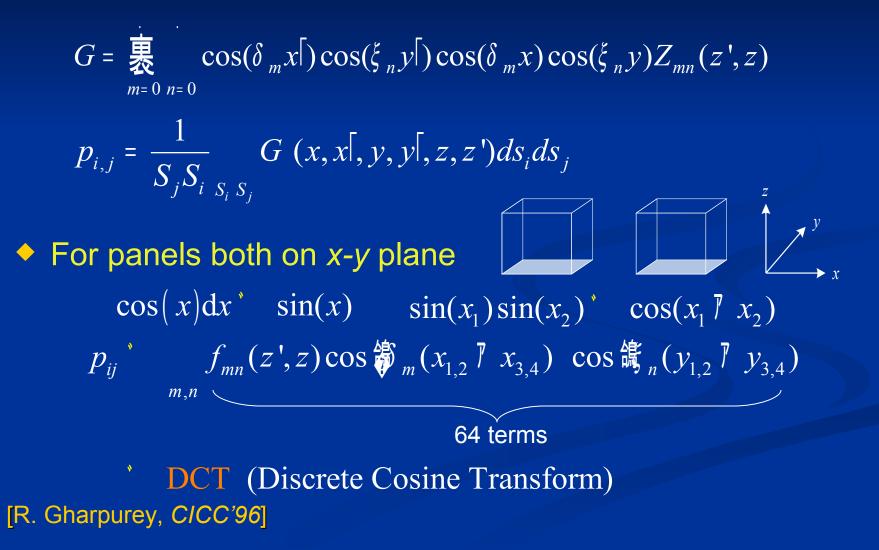
 $4 G(r',r) = -\frac{\delta(r-r')}{c}$  $\overline{G} = \overline{X(x', x)}\overline{Y(y', y)}\overline{Z(z', z)}$  $\dot{\varepsilon} = \varepsilon + \frac{\sigma}{i\omega}$  (complex permittivity)  $X(x',x) = \cos(\frac{m\pi}{a}x')\cos(\frac{m\pi}{a}x)$  $Y(x',x) = \cos(\frac{n\pi}{h}y')\cos(\frac{n\pi}{h}y)$  $t_N$ Z(z',z) subjects to:  $\mathcal{E}_N$ field •  $Z^l_{m k}(z')=Z^{m u}_{m k}(z')$  $t_1$  $\frac{\mathrm{d}Z_k}{\mathrm{d}z} \Big|_{z'-\delta_m}^{z'+\delta_m} = -\frac{C_{mn}}{ab\epsilon_k}$  $\varphi = 0$  at z = 0• source  $t_0$  $|Z_k|_{z=z_k} = Z_{k-1}|_{z=z_k}$  $\frac{\partial \varphi}{\partial p} = 0$  on  $\mathcal{E}_0$  $\epsilon_k \frac{\mathrm{d}Z_k}{\mathrm{d}z} \Big|_{z=z_k} = \epsilon_{k-1} \frac{\mathrm{d}Z_{k-1}}{\mathrm{d}z} \Big|_{z=z_k}$ z = 0other surfaces  $Z_0|_{z=0}=0$ 

 $\frac{\mathrm{d}\mathbf{Z}_{\mathbf{N}}}{\mathrm{d}\mathbf{z}}\Big|_{\boldsymbol{z}=\boldsymbol{z}_{\boldsymbol{N}+1}}=\mathbf{0}$ 

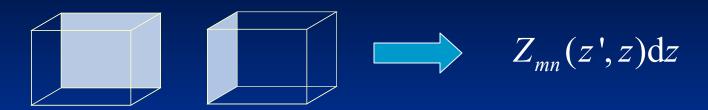
[R. Gharpurey, CICC'96]

### Integration for the Coefficient of Potential

#### Green's function



### For Sidewall Panels...



Gharpurey'96 (original one)

$$Z_{mn}(z',z) = \frac{f_{mn}(z')}{\beta_s^{\ u}\Gamma_s^{\ l} - \beta_s^{\ l}\Gamma_s^{\ u}} \bar{7} \overset{(u,l)}{\not \beta_s^{\ u}\Gamma_s^{\ l} - \beta_s^{\ l}\Gamma_s^{\ u}} \bar{7} \overset{(u,l)}{\not \beta_s^{\ u,l}} \underline{\cosh(\gamma_{mn}z)} + \Gamma_f^{\ u,l} \underline{\sinh(\gamma_{mn}z)}$$

numerically instable when  $\gamma_{mn}$  grows

♦ Niknejad'98 (resolved the numerical stability)  $Z_{mn}(z',z) = \frac{4F_k^l(z_f,z_s)}{ab\varepsilon_k\gamma_{mn}} \text{ iff ] } (\text{ iff } \text{I} \frac{\cosh(\vartheta_f - \vartheta_f)\cosh(\vartheta_f - \vartheta_{k+1})}{\cosh(\vartheta_f - \vartheta_k)}$ stable but cannot be integrated analytically

able but carmot be integrated analytically

[A.M. Niknejad, TCAD'98]

### Numerically Stable and Analytically Integrable Formula

# replace the hyperbolic functions to exponential ones: $e^{x} + e^{-x}$

$$\cosh(x) = \frac{e^{-r} + e^{-r}}{2}, \quad \sinh(x) = \frac{e^{-r} - e^{-r}}{2},$$

$$Z_{mn}(z',z) = \frac{C_{mn}}{ab\varepsilon_{s}\gamma_{mn}} \frac{1}{7} \frac{\left(\alpha_{s}^{u,l}e^{\gamma_{mn}z'} + \beta_{s}^{u,l}e^{-\gamma_{mn}z'}\right)\left(\alpha_{f}^{u,l}e^{\gamma_{mn}z} + \beta_{f}^{u,l}e^{-\gamma_{mn}z}\right)}{\alpha_{s}^{u}\beta_{s}^{l} - \alpha_{s}^{l}\beta_{s}^{u}}$$

#### recursive procedure for the coefficients

$$\overset{k}{\underset{m}{\mathfrak{g}}} \overset{l}{\underset{k}{\mathfrak{g}}} = \frac{1}{2} \overset{{\underset{m}{\mathfrak{g}}}(1+p_{k})e^{\gamma_{mn}t_{k-1}}}{\underset{m}{\mathfrak{g}}(1-p_{k})e^{\gamma_{mn}t_{k-1}}} \frac{(1-p_{k})e^{-\gamma_{mn}t_{k-1}}}{(1+p_{k})e^{\gamma_{mn}t_{k-1}}} \overset{{\underset{m}{\mathfrak{g}}}{\underset{k-1}{\mathfrak{g}}}$$

#### Integration

$$Z_{mn}(z',z)dz = \frac{X}{\gamma_{mn}} \overline{7} \left( \alpha_{f}^{u,l} e^{\gamma_{mn}z} - \beta_{f}^{u,l} e^{-\gamma_{mn}z} \right)$$

# **Stability-Preserving Technique**

#### Instability:

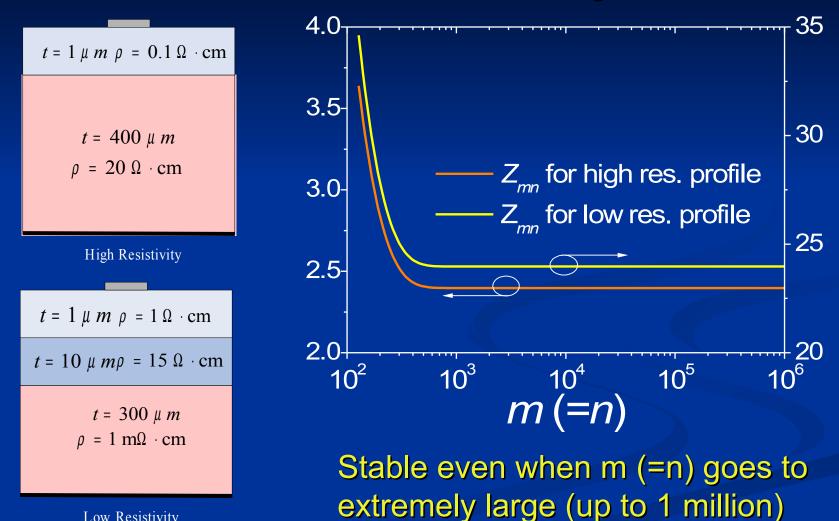
- $e^{\gamma_{mn}t_{k-1}}$  overflows when  $\gamma_{mn}$  becomes large
- Solution:
  - Define super complex number (hi\_cplx)

hi\_cplx 
$$z = ae^x \frac{a \ddagger \mathbf{C}}{x \ddagger \mathbf{R}}$$

Re-define (overload) the operators (+,-,\*,/) to avoid the overflow.

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1216 1217			= abs(a) 100.0	);  s < 1e-2)			
1218 1219			log(s);				
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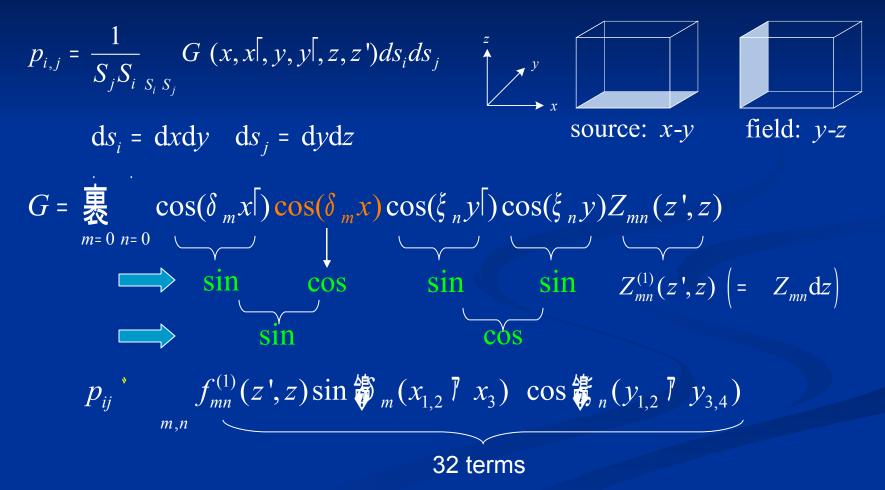
# **Numerical Stability**



Low Resistivity

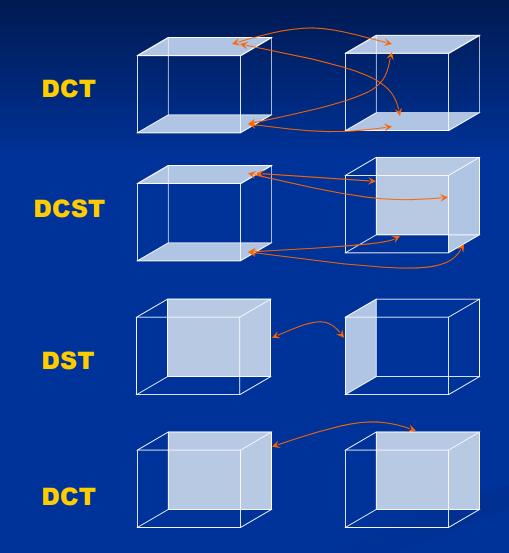
[J.P. Costa, TCAD'99]

### Coefficient-of-Potential Involving Sidewalls: xy-yz



**DCST** (Discrete Cosine-Sine Transform)

# **All Positional Relations**



- Consider totally 10 situations classified to 4 types
- For each situation, a Green's function should be computed and stored
- It required about 10X of that cost by ASITIC

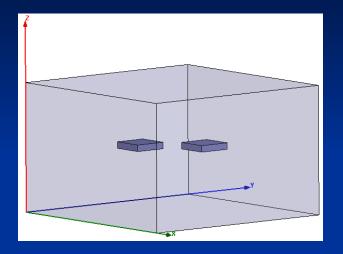
 Can be reduced by applying non-uniform grid

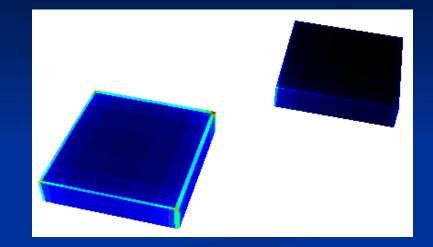
### Non-uniform Grid Method for Computing Green's Function

### 

- Computational amount  $O(N^2 \log(N^2))$
- Memory required: O(N<sup>2</sup>) (N: FFT size, ~2000, increases with shrinking metal width)
- Non-uniform grid method have been developed (but not presented in the proceedings)
  - Computational amount  $O(M^2 N_c^2)$
  - Memory required:  $O(N_c^2)$
  - Nc: non-uniform grid size, <40; M: ~64 (constant)</p>

### **Test Case I: Two contacts**

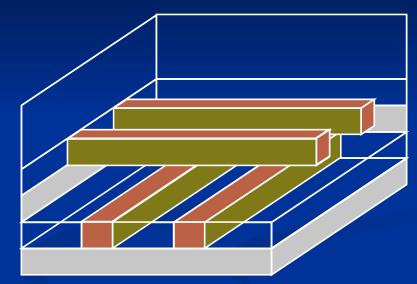




	C11 (F)	Error (%)	C12 (F)	Error (%)
Ansys	6.2520e-15		-1.5668e-15	))
ASITIC	5.0121e-15	-19.8	-9.7422e-16	-37.8
SCAPE	6.2573e-15	-0.08	-1.5752e-15	0.54

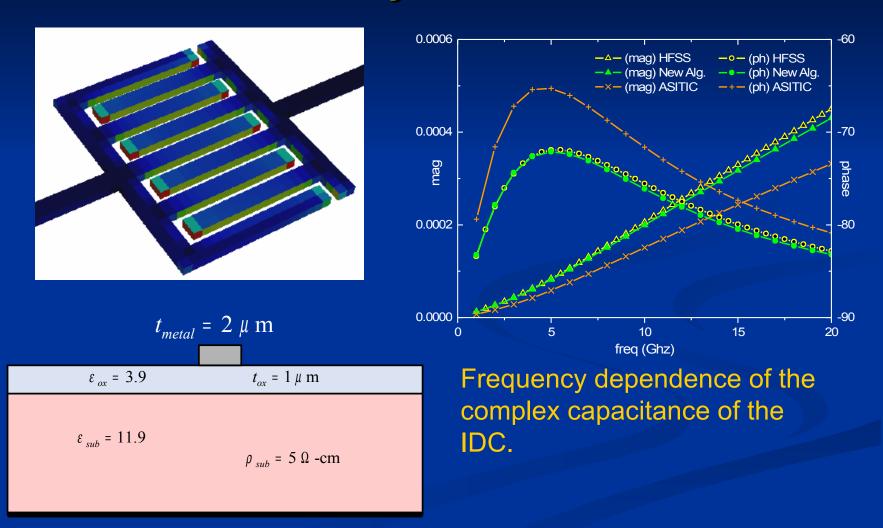
# Test Case II: k-by-k buses

Test problem								
	$2 \times 2$		4×4	$5 \times 5$				
FastCap I (with fine mesh)								
CPU Time (s)	54	120	218	349				
Memory (MB)	111	131	160	197				
Panel #	7812	8724	9948	11492				
FastCap II (with coarse mesh)								
CPU Time (s)	11.6	19.1	31.1	46.6				
Memory (MB)	56	64	75	89				
Panel #	3628	4080	4684	5448				
Error (%)	2.89	2.84	2.85	2.76				
ASITIC								
Panel #	50	84	144	220				
Error (%)	23.7	24.8	25.8	25.4				
SCAPE								
CPU time (s)	0.32	1.14	3.41	8.39				
Memory (MB)	19	20	21	25				
Panel #	146	276	464	700				
Error (%)	0.99	0.91	1.60	2.38				



Green's function method does not need to discretize the interfaces of dielectrics

### Test case III: Interdigital Capacitor (IDC) over Lossy Substrate



# Conclusion

 3-D capacitance extraction based on Green's function

- Stable and analytically integrable formula for the Green's function in z-direction
- Accurate result compared with well tested solvers (FastCap, Ansys, HFSS)
- Limitation: layered dielectric, Manhattan conductor

# Thank you